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PUBLISHING EDITOR Andreas Thoss, e-mail: editor@methodsmicroscopy.org

EDITOR-IN-CHIEF Roger Wepf, Centre for Microscopy and Microanalysis - CMM, The University of Queensland/ St Lucia, Brisbane, Queensland, Australia

EDITOR Martin Friedrich, e-mail: editor@methodsmicroscopy.org

PUBLISHER Walter de Gruyter GmbH, Berlin/Boston, Genthiner Straße 13, 10785 Berlin, Germany

JOURNAL COORDINATOR Natalia Bialka, e-mail: natalia.bialka@degruyterbrill.com

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